

Notice of References Cited		Application/Control No. 09/768,464	Applicant(s)/Patent Under Reexamination OTSUKA ET AL.	
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U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-5907332	05-1999	Fujita et al.	347/15
B	US-			
C	US-			
D	US-			
E	US-			
F	US-			
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FOREIGN PATENT DOCUMENTS

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